

**Notice of References Cited**

Application/Control No.

10/550,577

Applicant(s)/Patent Under  
Reexamination  
HAYASHI ET AL.

Examiner

/Susan W. Berman/

Art Unit

1796

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,079,041	03-1978	Baumann et al.	526/258
*	B	US-7,371,783	05-2008	Tatsuzawa et al.	522/176
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	O					
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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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